# **ELECTRONIC SUPPLEMENTARY INFORMATION**

# **Steady Shear Microstructure in Dilute Colloid-Polymer Mixtures**

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### CALCULATION OF THE INTERPARTICLE POTENTIAL AT CONTACT

The interparticle depletion potential,  $u_{dep}(r)$ , between hard sphere colloids of radius *a* in the presence of non-adsorbing polymers for a net center-to-center separation, *r* is given by:

$$u_{dep}(r) = -\Pi \pi \left[ \frac{4}{3} \left( a + R_g \right)^3 \left( 1 - \frac{3r}{4 \left( a + R_g \right)} + \frac{r^3}{16 \left( a + R_g \right)^3} \right) \right], \ ^{1-2}$$

where  $\Pi$  represents the osmotic pressure induced by the polymer and  $R_g$  is the polymer's radius of gyration. The osmotic pressure is modeled through a virial equation of state according to:

$$\Pi = nkT(1+B_2n+\ldots),^3$$

where *n* is the polymer bulk number density, *k* is the Boltzmann's constant and *T* is the absolute temperature and  $B_2$  is the second virial coefficient, related to the depletant volume ( $V_p$ ):

$$B_2 = 4V_p = \frac{16}{3} \left( \pi R_g^{3} \right)$$

The magnitude of the interparticle electrostatic repulsion,  $u_{elec}(r)$  was estimated by inverting the 2D radial distribution function of a polymer-free suspension, g(r), using the hypernetted chain (HNC) approximation as described in reference [4]

$$u_{elec}(r) = w(r) + nkTI(r)$$

where *n* is the areal number density of particles, w(r) is the mean potential:

$$w(r) = -kT\ln g(r)$$

and I(r) represents the convolution integral:

$$I(r) = \int \left[ g(r') - 1 - nI(r) \right] \left[ g(|r'-r|) - 1 \right] d^2r'$$

The magnitude of the interparticle potential at contact,  $|U_{min}|$ , was estimated by extrapolating  $U(r) = u_{dep}(r) + u_{elec}(r)$  to the particle diameter.

$\begin{array}{c} \text{PS conc.} (C_p, \\ \text{mg/ml}) \rightarrow \\ \hline \dot{\gamma}, \text{ s}^{-1} \end{array}$	9.0	14.4	20.8
0.07	3.76E-03	1.50E-03	7.59E-04
0.14	7.53E-03	3.00E-03	1.52E-03
0.56	3.01E-02	1.20E-02	6.07E-03
2.24	1.20E-01	4.79E-02	2.43E-02
8.96	4.82E-01	1.92E-01	9.72E-02

# SUPPLEMENTARY TABLES & FIGURES

Table S1. Calculated values of the dimensionless shear rate,  $\dot{\gamma}^*$ , for PS Mw = 97,400 Da over the range of  $\dot{\gamma}$  and C<sub>p</sub> investigated.

$\frac{\text{PS conc. } (C_p, \\ \text{mg/ml}) \rightarrow}{\dot{\gamma}, \text{ s}^{-1}}$	4.5	7.2	10.4
0.07	7.88E-03	2.55E-03	1.20E-03
0.14	1.58E-02	5.10E-03	2.41E-03
0.56	6.31E-02	2.04E-02	9.63E-03
2.24	2.52E-01	8.16E-02	3.85E-02
8.96	1.01E+00	3.26E-01	1.54E-01

Table S2. Calculated values of the dimensionless shear rate,  $\dot{\gamma}^*$ , for PS Mw = 777,500 Da over the range of  $\dot{\gamma}$  and C<sub>p</sub> investigated.



Figure S1. Low magnification confocal micrographs of the terminal microstructure in the flow-vorticity plane at shear rate,  $\dot{\gamma} =$  (a) 0.14, (b) 0.56 and (c) 2.24 s<sup>-1</sup>. Scale bar corresponds to 300  $\mu$ m.



Figure S2. Overview of terminal cluster radius ( $R_c$ ) quantification: (a) Raw image, (b) processed image after morphing and dilation operations, (c) identification of clusters and (d) overlay of identified clusters. Scale bar represents 20  $\mu$ m.



Figure S3. Long-range reconstruction of the sheared microstructure at: (a)  $C_p = 20.8 \text{ mg/ml}$ ,  $M_w = 97,400 \text{ Da}$ , (b)  $C_p = 10.4 \text{ mg/ml}$ ,  $M_w = 777,500 \text{ Da}$ .  $\dot{\gamma}$  (from top to bottom) = 0.07, 0.14, 0.56, 2.24, 8.96 s<sup>-1</sup>. Scale bar represents 100 µm.



Figure S4. Probability distributions of: (a-c) nearest neighbors (P(NN)) and, (d-f) volumes of Voronoi polyhedra (P( $V_{VP}$ )) at three representative polymer concentrations. The symbols reported in the legend are common to all the plots.

# REFERENCES

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- 2. W. B. Russel, D. A. Saville and W. R. Schowalter, *Colloidal Dispersions*, Cambridge University Press, 1992.
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